

Preliminary

SIPC61N60S5

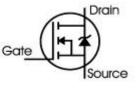
Fast CoolMOS[™] Power Transistor

FEATURES:

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- **Applications:**
- New revolutionary high voltage technology •
- Ultra low gate charge •
- •
- Worlbest $R_{DS(on)}$ per chip area Ultra low effective capacitances •
- Improved noise immunity •

SMPS, resonant applications



Chip Type	V _{DS}	I _D	Die Size	Package	Ordering Code	
SIPC61N60S5	600V	47A	10.00 x 6.20 mm ²	sawn on foil	Q67041- A4009-A001	

MECHANICAL PARAMETER:

Raster size	10.00 x 6.20	mm			
Source pad opening	7.0 x 5.6				
Gate pad size	0.433 x 0.567				
Area total / active	62.00 / 53.29	mm ²			
Thickness	175	μm			
Wafer size	150	mm			
Flat position	0	grd			
Max.possible chips per wafer	227				
Passivation frontside	Nitride				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond (proposed)	Source: Al, ≤ 500µm; Gate: Al, ≤ 125µm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month				



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Drain-Source voltage	V _{DS}	600	V
DC drain current, limited by T _{jmax}	I _D	47	А
Pulsed drain current, t _p limited by T _{jmax}	I _{Dpuls}	94	А
Gate source voltage	V _{GS}	±20	V
Operating junction and storage temperature	T _j , T _{stg}	-55 +150	°C
Reverse diode dv/dt I _S =47A, V _{DS} <v<sub>DSS, di/dt=100 A/µs, T_{jmax}=150°C</v<sub>	dv/dt	6	KV/µs

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
	Cymbol	Conditions	min.	typ.	max.	•
Drain-source breakdown voltage	V _{(BR)DSS}	V_{GS} =0V , I_D = 0.25mA			600	V
Gate-source on-state resistance	R _{DS(on)}	V _{GS} =10V, I _D =25A		70	90 ¹⁾	mΩ
Gate threshold voltage	V _{GS(th)}	I_D =2.7mA , V_{GS} = V_{DS}	3.5	4.5	5.5	V
Zero gate voltage drain current	I _{DSS}	V_{DS} =600V , V_{GS} =0V		0.1	25	μA
Gate-source leakage current	I _{GSS}	V_{DS} =0V , V_{GS} =20V			100	nA

¹⁾ this correlates to a max. $R_{DS(on)}$ -value of 70 m Ω at V_{GS}=10V, I_D=30A of this chip packaged in a TO247-package

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Input capacitance	Ciss	$V_{\rm DS}=25\rm V$,	-	7600		pF
Output capacitance	Coss	$V_{GS}=0V$,	-	2950		
Reverse transfer capacitance	Crss	f=1MHz	-	27		

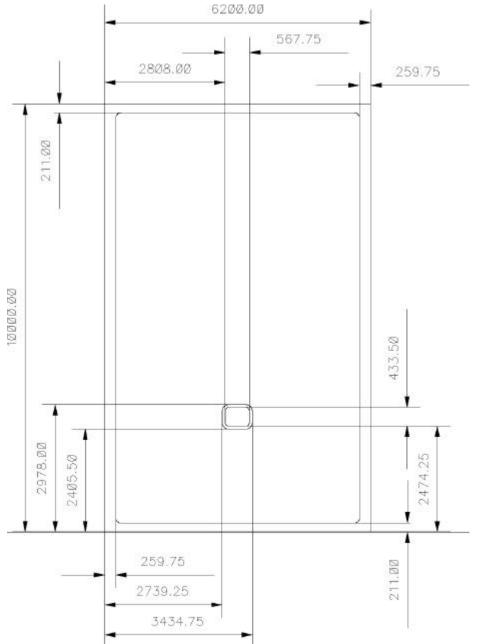
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions	Value			Unit
	Symbol		min.	typ.	max.	
Turn-on delay time	t _{d(on)}	<i>T</i> _j =25 ° C	-	360		ns
Rise time	t _r	$V_{DD} = 350 V,$	-	30		
Turn-off delay time	$t_{d(off)}$	V _{GS} =10V,	-	200		
Fall time	t _f	R _G = 1.3Ω	-	30		



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CHIP DRAWING:



FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the	
device data sheet	



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DESCRIPTION:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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